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- *EPIC*[™] (Enhanced-Performance Implanted CMOS) Process
- Inputs Are TTL-Voltage Compatible
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Package Options Include Plastic Small-Outline (DW), Shrink Small-Outline (DB), Thin Very Small-Outline (DGV), Thin Shrink Small-Outline (PW), and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) DIPs

description

The 'AHCT574 devices are octal edge-triggered D-type flip-flops that feature 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. These devices are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

On the positive transition of the clock (CLK) input, the Q outputs are set to the logic levels of the data (D) inputs.

A buffered output-enable (\overline{OE}) input places the eight outputs in either a normal logic state (high or low) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and the increased drive provide the capability to drive bus lines without interface or pullup components.

OE does not affect internal operations of the flip-flop. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN54AHCT574 is characterized for operation over the full military temperature range of -55° C to 125° C. The SN74AHCT574 is characterized for operation from -40° C to 85° C.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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| SN54AHCT574 J OR W PACKAGE |
|--|
| SN74AHCT574DB, DGV, DW, N, OR PW PACKAGE |
| |

| | (TOP VIEW) | | | | | | | | | | |
|--|---|--|---|--|--|--|--|--|--|--|--|
| OE 1D 2D 3D 4D 5D 6D 7D 8D | $\begin{bmatrix} 1\\ 2\\ 3\\ 4\\ 5\\ 6\\ 7\\ 8\\ 9 \end{bmatrix}$ | 200 200 19 18 17 16 15 14 13 12 | Vcc 1 Q 2 Q 3 Q 4 Q 5 Q 6 Q 7 Q 8 Q | | | | | | | | |
| GND | 10 | 11 | | | | | | | | | |
| | | | | | | | | | | | |

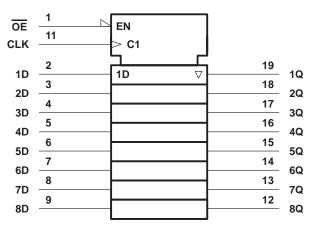
SN54AHCT574 . . . FK PACKAGE (TOP VIEW)

| | 2D 2C 2C 2C 2D | |
|----------------------------|------------------------------------|----------------|
| | | |
| 3D | 3 2 1 20 19 4 18 | 2Q 3Q 4Q |
| 3D 4D 5D 6D 7D | 5 17 | 3Q |
| 5D | П6 16 Г | 4Q |
| 6D | [7 15 [| 5Q |
| 7D | 8 | 6Q |
| | | |
| | 8D 6ND CLK 8Q 8Q 7Q | |

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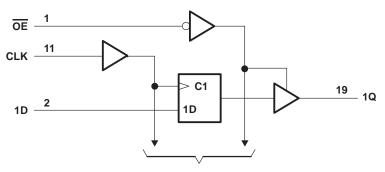
| FUNCTION TABLE (each flip-flop) | | | | | | | | | |
|------------------------------------|------------|---|----------------|--|--|--|--|--|--|
| INPUTS OUTPUT | | | | | | | | | |
| OE | CLK | Q | | | | | | | |
| L | \uparrow | Н | Н | | | | | | |
| L | \uparrow | L | L | | | | | | |
| L | H or L | Х | Q ₀ | | | | | | |
| Н | Х | Х | Z | | | | | | |

logic symbol[†]



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



To Seven Other Channels



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

| Supply voltage range, V_{CC} |
|--|
| |
| DW package |
| N package 69°C/W |
| PW package |
| Storage temperature range, T _{stg} –65°C to 150°C |

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions (see Note 3)

| | | SN54AHCT574 | | SN74AH | UNIT | |
|---------------------|------------------------------------|-------------|-----|--------|------|------|
| | | MIN | MAX | MIN | MAX | UNIT |
| VCC | Supply voltage | 4.5 | 5.5 | 4.5 | 5.5 | V |
| VIH | High-level input voltage | 2 | | 2 | | V |
| VIL | Low-level input voltage | | 0.8 | | 0.8 | V |
| VI | Input voltage | 0 | 5.5 | 0 | 5.5 | V |
| VO | Output voltage | 0 | VCC | 0 | VCC | V |
| ЮН | High-level output current | | -8 | | -8 | mA |
| IOL | Low-level output current | | 8 | | 8 | mA |
| $\Delta t/\Delta v$ | Input transition rise or fall rate | | 20 | | 20 | ns/V |
| ТА | Operating free-air temperature | -55 | 125 | -40 | 85 | °C |

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | Vee | Т | λ = 25°C | ; | SN54AH | CT574 | SN74AH | CT574 | UNIT |
|-----------------|---|--------------|------|----------|-------|--------|-------|--------|-------|------|
| PARAMETER | TEST CONDITIONS | Vcc | MIN | TYP | MAX | MIN | MAX | MIN | MAX | UNIT |
| Veri | I _{OH} = -50 μA | 4.5 V | 4.4 | 4.5 | | 4.4 | | 4.4 | | V |
| Vон | I _{OH} = –8 mA | 4.5 V | 3.94 | | | 3.8 | | 3.8 | | v |
| Ve | I _{OL} = 50 μA | 4.5 V | | | 0.1 | | 0.1 | | 0.1 | V |
| VOL | I _{OL} = 8 mA | 4.5 V | | | 0.36 | | 0.44 | | 0.44 | v |
| lj | $V_I = V_{CC}$ or GND | 0 V to 5.5 V | | | ±0.1 | | ±1* | | ±1 | μΑ |
| I _{OZ} | $V_{O} = V_{CC}$ or GND | 5.5 V | | | ±0.25 | | ±2.5 | | ±2.5 | μA |
| ICC | $V_{I} = V_{CC} \text{ or GND}, \qquad I_{O} = 0$ | 5.5 V | | | 4 | | 40 | | 40 | μΑ |
| ∆lcc‡ | One input at 3.4 V, Other inputs at V_{CC} or GND | 5.5 V | | | 1.35 | | 1.5 | | 1.5 | mA |
| Ci | $V_I = V_{CC}$ or GND | 5 V | | 3 | 10 | | | | 10 | pF |
| Co | $V_{O} = V_{CC}$ or GND | 5 V | | 3 | | | | | | pF |

* On products compliant to MIL-PRF-38535, this parameter is not production tested at V_{CC} = 0 V.

[†] This is the increase in supply current for each input at one of the specified TTL voltage levels rather than 0 V or V_{CC}.

timing requirements over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

| | | T _A = 25°C | | T _A = 25°C | | T _A = 25°C SN54AHCT574 | | SN74AH | UNIT |
|-----------------|--|-----------------------|-----|-----------------------|-----|-----------------------------------|-----|--------|------|
| | | MIN | MAX | MIN | MAX | MIN | MAX | UNIT | |
| tw | Pulse duration, CLK high or low | 5 | | 5.5 | | 5.5 | | ns | |
| t _{su} | Setup time, data before CLK [↑] | 3 | | 3.5 | | 3.5 | | ns | |
| th | Hold time, data after CLK↑ | 1.5 | | 1.5 | | 1.5 | | ns | |

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

| PARAMETER | FROM | то | LOAD | Т | A = 25°C | ; | SN54AH | ICT574 | SN74AH | CT574 | UNIT | |
|--------------------|---------|----------|--------------------------|------------------------|----------|-------|--------|--------|--------|-------|--------|-----|
| PARAMETER | (INPUT) | (OUTPUT) | CAPACITANCE | MIN | TYP | MAX | MIN | MAX | MIN | MAX | UNIT | |
| 4 | | | CL = 15 pF | 130** | 180** | | 110** | | 110 | | MHz | |
| fmax | | | CL = 50 pF | 85 | 115 | | 75 | | 75 | | IVITIZ | |
| ^t PLH | CLK | Q | C _L = 15 pF | | 5.5** | 8.6** | 1** | 10** | 1 | 10 | ns | |
| ^t PHL | ULK | Q | | | 5.5** | 8.6** | 1** | 10** | 1 | 10 | 115 | |
| ^t PZH | ŌĒ | Q | Ci = 15 pF | | 5** | 9** | 1** | 10.5** | 1 | 10.5 | ns | |
| ^t PZL | | | C _L = 15 pF | | 5** | 9** | 1** | 10.5** | 1 | 10.5 | 115 | |
| ^t PHZ | OE | = 0 | Q C _I = 15 pF | | 5.5** | 9** | 1** | 10.5** | 1 | 10.5 | ns | |
| ^t PLZ | ÛE | ÛE | Q | | | 5.5** | 9** | 1** | 10.5** | 1 | 10.5 | 115 |
| ^t PLH | CLK | 0 | Q | C _I = 50 pF | | 7 | 10.6 | 1 | 12 | 1 | 12 | ns |
| ^t PHL | ULK | Q | CL = 50 pr | | 7 | 10.6 | 1 | 12 | 1 | 12 | 115 | |
| ^t PZH | OE | Q | C _L = 50 pF | | 6 | 11 | 1 | 12.5 | 1 | 12.5 | ns | |
| ^t PZL | ÛE | Q | CL = 30 pr | | 6 | 11 | 1 | 12.5 | 1 | 12.5 | 115 | |
| ^t PHZ | OE | Q | $C_{\rm L} = 50 \rm pE$ | | 7 | 10.1 | 1 | 11.5 | 1 | 11.5 | ns | |
| ^t PLZ | | Q | CL = 50 pF | | 7 | 10.1 | 1 | 11.5 | 1 | 11.5 | 115 | |
| ^t sk(o) | | | C _L = 50 pF | | | 1*** | | | | 1 | ns | |

** On products compliant to MIL-PRF-38535, this parameter is not production tested.

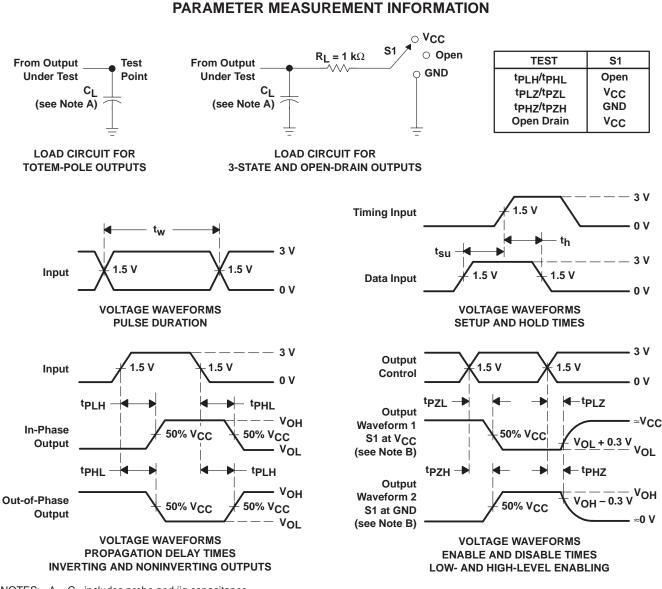
*** On products compliant to MIL-PRF-38535, this parameter does not apply.



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operating characteristics, $V_{CC} = 5 V$, $T_A = 25^{\circ}C$

| | PARAMETER | TEST CO | ONDITIONS | TYP | UNIT |
|-----------------|-------------------------------|----------|-----------|-----|------|
| C _{pd} | Power dissipation capacitance | No load, | f = 1 MHz | 28 | pF |



NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_O = 50 Ω , t_f \leq 3 ns, t_f \leq 3 ns.

D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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